

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/039,100	YIP ET AL.		
Examiner	Art Unit		
Twyler M. Lamb	2622		

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	2/2/2006	TML	
358/1.13-1.18 , 1.2, 462, 464, 299, 1.1, 1.9, 401, 442, 452(WITH TERMS)	2/2/2006	TML	
382/295, 298 (WITH TERMS)	2/2/2006	TML	